Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination KONDO, TAKAYUKI	
10/673,444		
Examiner	Art Unit	
John D. Lee	2874	

	0545					
	SEARCHED					
Class	Subclass	Date	Examiner			
385	14,15,27, 37,88,89, 129,130	10/11/2006	JDL			
385	147	10/11/2006	JDL			
398	82	10/11/2006	JDL			
(То	Date)					
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			

(INCLUDING SEARCH	TES STRATEGY))
	DATE	EXMR
Previous EAST search (05/24/05) updated; same search terms.	10/11/2006	JDL
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